

Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
128594APPLICATION NO.
10/585,821

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Yuichiro OGAWAFILING DATE
May 31, 2007GROUP
1733

U.S. PATENT DOCUMENTS

| Examiner Initials | Cite No. | Document Number | Date | Name |
|-------------------|----------|-----------------|------------|---------------------|
| | 1. | 6,022,434 | 02/08/2000 | WILLARD, JR. et al. |
| | 2. | 2002/0009608 A1 | 01/24/2002 | NISHIKAWA et al. |
| | 3. | 3,509,930 | 05/05/1970 | MIRTAİN |
| | 4. | 4,024,901 | 05/24/1977 | POQUÉ |
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FOREIGN PATENT DOCUMENTS

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| | 5. | EP 0 778 161 A1 | 06/11/1997 | EUROPE | | |
| | 6. | EP 1 101 597 A2 | 05/23/2001 | EUROPE | | |
| | 7. | FR 2 286 014 A | 04/23/1976 | FRANCE | | |
| | 8. | EP 1 002 668 A2 | 05/24/2000 | EUROPE | | |
| | 9. | JP-A-08-175122 | 07/09/1996 | JAPAN | X | X |
| | 10. | JP-A-05-042803 | 02/23/1993 | JAPAN | X | X |

OTHER DOCUMENTS

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EXAMINER

DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: January 24, 2008